TOSHIBA Intelligent Power Device Silicon Monolithic Power MOS Integrated Circuit

# **TPD2005F**

Low-Side Power Switch Array (8 Channels) for Motors, Solenoids, and Lamp Drivers

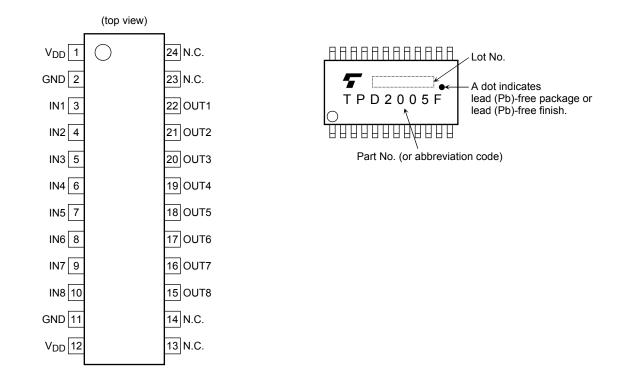
The TPD2005F is an 8-channel high-side switch array for vertical power MOS FET output. A monolithic power IC, it can directly drive a power load from a CMOS or TTL logic circuit (such as an MPU). It offers overcurrent and overtemperature protection functions.

#### Features

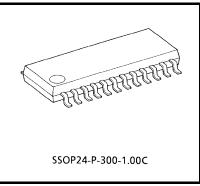
- A high-side switch array incorporating an N-channel power MOS FET (1.2 Ωmax.) and an 8-channel charge pump
- Can directly drive a power load from a microprocessor.
- Built-in protection against thermal shutdown protection and overcurrent protection
- 8-channel access enables space-saving design
- High operating voltage : 40 V
- Low on resistance  $: 1.2 \Omega$ max. (@V<sub>DD</sub> = 12 V, I<sub>O</sub> = 0.5 A (per channel))
- Supports parallel operation.
- Low operating current  $: 5 \text{ mA max.} (@V_{DD} = 40 \text{ V}, \text{V}_{IN} = 0 \text{ V})$
- Supplied in an SSOP-24 package (300 mil) in embossed taping.



#### Marking

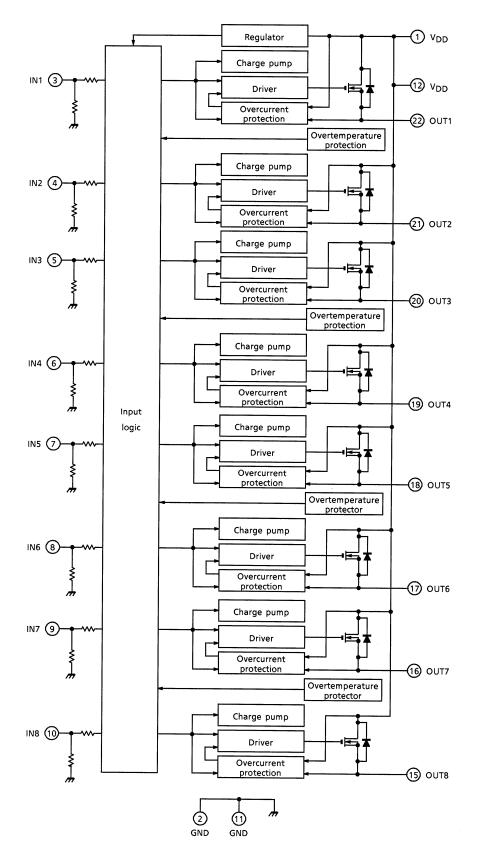


Note: Due to its MOS structure, this product is sensitive to static electricity.



Weight: 0.29g (typ.)

#### **Block Diagram**

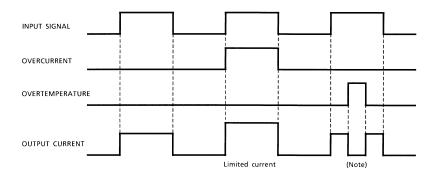


# <u>TOSHIBA</u>

#### **Pin Description**

Pin No.	Symbol	Description
1	V <sub>DD</sub>	Power supply pin; in common with the pin No.12 internally.
2	GND	GND pin; in common with the pin No.11 internally.
3	IN1	Control input pin for channel 1 and built-in pull-down resistor (100 kΩ typ.)
4	IN2	Control input pin for channel 2 and built-in pull-down resistor (100 k $\Omega$ typ.)
5	IN3	Control input pin for channel 3 and built-in pull-down resistor (100 k $\Omega$ typ.)
6	IN4	Control input pin for channel 4 and built-in pull-down resistor (100 k $\Omega$ typ.)
7	IN5	Control input pin for channel 5 and built-in pull-down resistor (100 k $\Omega$ typ.)
8	IN6	Control input pin for channel 6 and built-in pull-down resistor (100 k $\Omega$ typ.)
9	IN7	Control input pin for channel 7 and built-in pull-down resistor (100 k $\Omega$ typ.)
10	IN8	Control input pin for channel 8 and built-in pull-down resistor (100 k $\Omega$ typ.)
11	GND	GND pin; in common with the pin No.2 internally.
12	V <sub>DD</sub>	Power supply pin; in common with the pin No.1 internally.
13	N.C.	—
14	N.C.	—
15	OUT8	Output pin for channel 8
16	OUT7	Output pin for channel 7
17	OUT6	Output pin for channel 6
18	OUT5	Output pin for channel 5
19	OUT4	Output pin for channel 4
20	OUT3	Output pin for channel 3
21	OUT2	Output pin for channel 2
22	OUT1	Output pin for channel 1
23	N.C.	_
24	N.C.	_

### **Timing Chart**



Note: The overheating detector circuits feature hysteresis. After overheating is detected, normal operation is restored only when the junction temperature falls by the hysteresis amount (10°C typ.) in relation to the overheating detection temperature.

#### **Truth Table**

Input Signal	Output Signal	State		
L	L	Normal		
н	Н	Norma		
L	L	Overcurrent		
Н	Internally limited	Overcuirent		
L	L	Overtemperature		
Н	L	Overtemperature		

#### Absolute Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit	
Supply voltage	V <sub>DD</sub>	45	V	
Input voltage	V <sub>IN</sub>	- 0.5 ~ 7	V	
Drain-source voltage	V <sub>DS</sub>	60	V	
Output current	IO	Internally limited	А	
Power dissipation	Рт	0.8	w	
(operating all channels, ta = 25°C)	1.2 (Note)	vV		
Single pulse avalanche energy	E <sub>AS</sub>	10	mJ	
Operating temperature	T <sub>opr</sub>	- 40 ~ 85	°C	
Junction temperature	Тj	150	°C	
Storage temperature	T <sub>stg</sub>	- 55 ~ 150	°C	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Thermal Characteristics**

Characteristic	Symbol	Rating	Unit	
Thermal resistance junction to ambient	ΣΡιμαίου	156.3	°C / W	
(Operating all channels, Ta = 25°C)	ΣR <sub>th (j-a)</sub>	104.2 (Note)		

Note: 60 mm × 60 mm × 1.6 mm when a device is mounted on a glass epoxy PCB (DC).

#### Electrical Characteristics (Unless otherwise specified, V<sub>DD</sub> = 8 ~ 40V, T<sub>i</sub> = 25°C)

Characteristic		Symbol	Test Cir- cuit	Test Condition	Min	Тур.	Max	Unit
Operating supply voltage		V <sub>DD</sub>	-	_	8	_	40	V
Supply current		I <sub>DD</sub>	—	V <sub>DD</sub> = 40 V, V <sub>IN</sub> = 0 V	-	-	5	mA
la se sta sa lta sa s	"L" level	VIL	—		_	_	1.5	v
Input voltage	"H" level	VIH	—		3.5	_	_	
Input current		IIL	—	V <sub>DD</sub> = 24 V, V <sub>IN</sub> = 0 V	-10	_	10	μA
		IIН	—	V <sub>DD</sub> = 24 V, V <sub>IN</sub> = 5V	_	50	200	
On resistance		R <sub>DS (ON)</sub>	—	V <sub>DD</sub> = 12 V, I <sub>O</sub> = 0.5 A	_	0.9	1.2	Ω
Output leakage current		I <sub>OL</sub>	—	V <sub>DD</sub> = 40 V, V <sub>IN</sub> = 0 V	_	_	100	μA
Overcurrent protection		IS	—	_	1	_	3	А
Thermal shutdown		T <sub>SD</sub>	—	_	_	160	_	°C
		ΔT <sub>SD</sub>	—	_	_	10	_	°C
Switching time		t <sub>ON</sub>	1	V	—	11	200	μs
		tOFF	1	V <sub>DD</sub> = 12 V, R <sub>L</sub> = 24Ω	_	4	50	

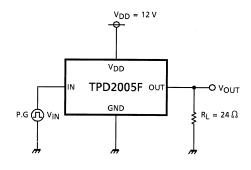
#### **Description of Protector Circuit**

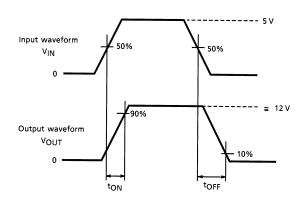
(1) Overtemperature Protection

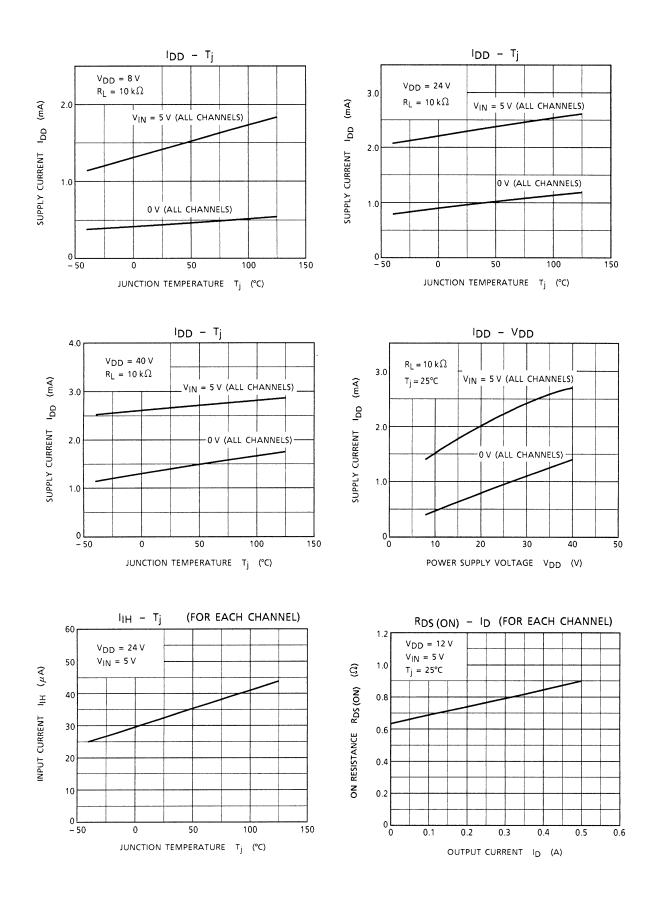
- There are four built-in overheating detector circuits, one each for channels 1 and 2; channels 3 and 4; channels 5 and 6; and channels 7 and 8, respectively. The circuit logic is such that, when any of the four detectors detects overheating, the circuit turns off the output of both its channels(for example, both channels 1 and 2).
- The overheating detector circuits feature hysteresis. After overheating is detected, normal operation is restored only when the junction temperature falls by the hysteresis amount (10°C typ.) in relation to the overheating detection temperature.
- (2) Overcurrent Protection
  - When overcurrent is detected, the overcurrent limiter function limits the output current. Normal operation is restored when the load current drops below the overcurrent detection value.

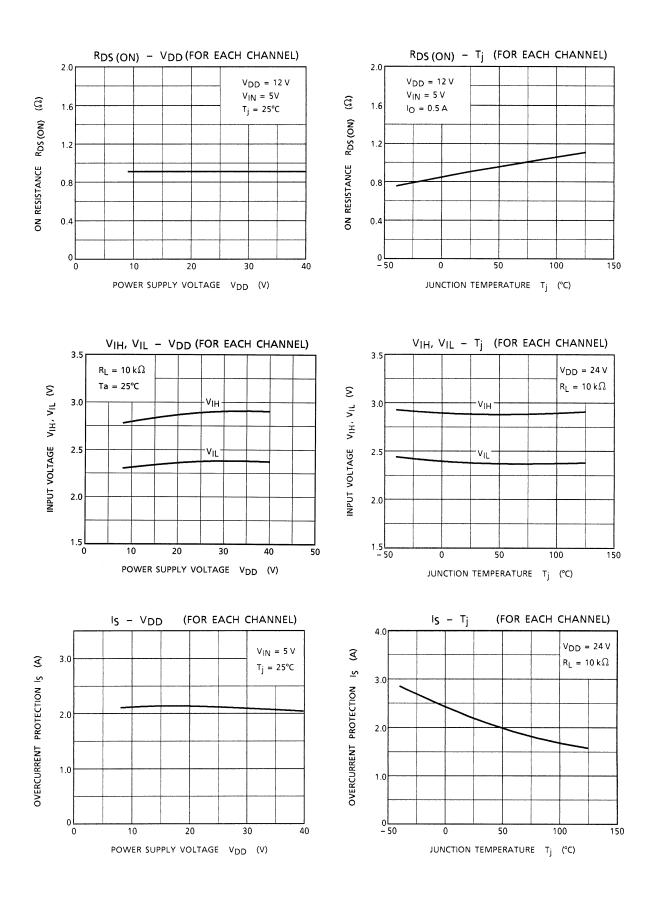
#### **Test Circuit**

Switching Time

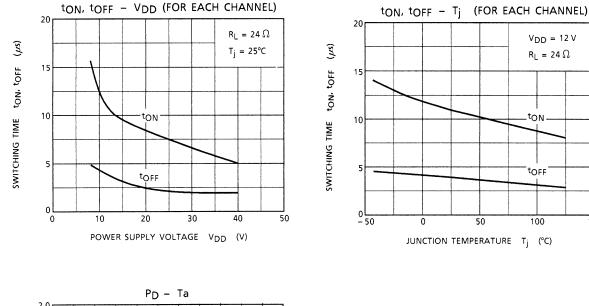


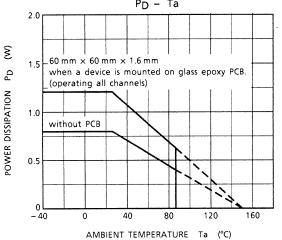


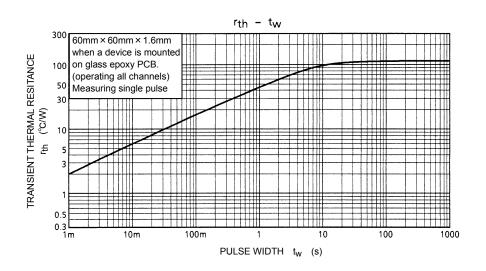




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#### **Caution on Usage**

- 1. As protection against reverse connection of batteries is not provided, take protective measures using external circuits.
- 2. As a negative bias protector circuit is not built into the output pins, if negative bias is applied to the output pins, be sure to connect a freewheel diode between OUT and GND.

#### **Moisture-Proof Packing**

After the pack is opened, use the devices in a 30°C, 60% RH environment, and within 48 hours.

Embossed-tape packing cannot be baked. Devices so packed must be within their allowable time limits after unpacking, as specified on the packing.

Standard tape packing quantity: 2000 devices / reel (EL1)

### Package Dimensions

SSOP24-P-300-1.00C Unit: mm 24 13 月月月月月月月月月月 6.0±0.2 (300mil) 8.0±0.3 7.62 日間 BBBB H 12 1 0.4±0.1 ⊕ 0.2 ⊛ <u>1.0TYP</u> 1.0 13.5MAX 13.0±0.2 60.07 1.5±0.2 1.9MAX 0.15

☑ 0.1

 $0.1^{+0.1}_{-0.05}$ 

Weight: 0.29g (typ.)

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0.45±0.2

#### **RESTRICTIONS ON PRODUCT USE**

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